Search Notes		

1 1001 1001	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/821,527	YANG ET AL.	
	Examiner	Art Unit	
	Hieu Nguyen	2817	

SEARCHED			
Class	Subclass	Date	Examiner
330	10	8/26/2005	НИ
330	207A	8/25/2005	HN
330	251	8/25/2005	HN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
MOTTOLA STEVEN J	8/30/2005	HN
NGUYEN KHANH V	8/29/2005	ни
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